MTM10N06E
MTP10N06E

Designer's Data Sheet

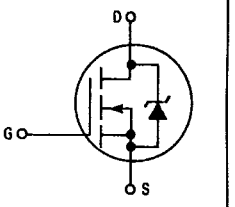
TMOS IV
Power Field Effect Transistors
N-Channel Enhancement-Mode Silicon Gate

TMOS POWER FETs
10 AMPERES
$r_{DS(on)}$ = 0.20 OHM
60 VOLTS

This advanced "E" series of TMOS power MOSFETs is designed to withstand high energy in the avalanche and commutation modes. These new energy efficient devices also offer drain-to-source diodes with fast recovery times. Designed for low voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating area are critical, and offer additional safety margin against unexpected voltage transients.

- Internal Source-to-Drain Diode Designed to Replace External Zener Transient Suppressor — Absorbs High Energy in the Avalanche Mode — Unclamped Inductive Switching (UIS) Energy Capability Specified at 100°C.
- Commutating Safe Operating Area (CSOA) Specified for Use in Half and Full Bridge Circuits
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits

TMOS™

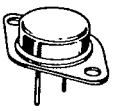


MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

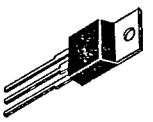
Rating	Symbol	MTM10N06E MTP10N06E	Unit
Drain-Source Voltage	V_{DSS}	60	Vdc
Drain-Gate Voltage (R_{GS} = 1 MΩ)	V_{DGR}	60	Vdc
Gate-Source Voltage — Continuous — Non-repetitive ($t_p \leq 50\ \mu s$)	V_{GS} V_{GSM}	±20 ±40	Vdc Vpk
Drain Current — Continuous — Pulsed	I_D I_{DM}	10 28	Adc
Total Power Dissipation @ T_C = 25°C Derate above 25°C	P_D	75 0.6	Watts W/°C
Operating and Storage Temperature Range	T_J, T_{stg}	−65 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance			°C/W
Junction to Case	$R_{\theta JC}$	1.67	
Junction to Ambient MTM10N06E	$R_{\theta JA}$	30	
Junction to Ambient MTP10N06E		62.5	
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	T_L	275	°C



MTM10N06E
CASE 1-04
TO-204AA



MTP10N06E
CASE 221A-04
TO-220AB

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Drain-Source Breakdown Voltage (V_{GS} = 0, I_D = 0.25 mA) MTM/MTP10N06E	$V_{(BR)DSS}$	60	—	Vdc
Zero Gate Voltage Drain Current (V_{DS} = Rated V_{DSS}, V_{GS} = 0)	I_{DSS}	—	10	μA
(V_{DS} = Rated V_{DSS}, V_{GS} = 0, T_J = 125°C)		—	100	
Gate-Body Leakage Current, Forward (V_{GSF} = 20 Vdc, V_{DS} = 0)	I_{GSSF}	—	100	nAdc
Gate-Body Leakage Current, Reverse (V_{GSR} = 20 Vdc, V_{DS} = 0)	I_{GSSR}	—	100	nAdc
ON CHARACTERISTICS*				
Gate Threshold Voltage (V_{DS} = V_{GS}, I_D = 1 mA)	$V_{GS(th)}$	2	4.5	Vdc
T_J = 100°C		1.5	4	
Static Drain-Source On-Resistance (V_{GS} = 10 Vdc, I_D = 5 Adc)	$r_{DS(on)}$	—	0.2	Ohm
Drain-Source On-Voltage (V_{GS} = 10 V) (I_D = 10 Adc)	$V_{DS(on)}$	—	2.2	Vdc
(I_D = 5 Adc, T_J = 100°C)		—	1.5	
Forward Transconductance (V_{DS} = 15 V, I_D = 5 A)	g_{FS}	3.8	—	mhos
DRAIN-TO-SOURCE AVALANCHE STRESS CAPABILITY				
Unclamped Inductive Switching Energy See Figures 14 and 15 (I_D = 28 A, V_{DD} = 10 V, T_C = 25°C, Single Pulse, Non-repetitive)	W_{DSR}	—	35	mJ
(I_D = 10 A, V_{DD} = 10 V, T_C = 25°C, P.W. ≤ 200 μs, Duty Cycle ≤ 1%)		—	55	
(I_D = 4 A, V_{DD} = 10 V, T_C = 100°C, P.W. ≤ 200 μs, Duty Cycle ≤ 1%)		—	22	
DYNAMIC CHARACTERISTICS				
Input Capacitance (V_{DS} = 25 V, V_{GS} = 0, f = 1 MHz, See Figure 16)	C_{iss}	—	600	pF
Output Capacitance	C_{oss}	—	350	
Reverse Transfer Capacitance	C_{rss}	—	100	
SWITCHING CHARACTERISTICS* (T_J = 100°C)				
Turn-On Delay Time (V_{DD} = 25 V, I_D = 0.5 Rated I_D, R_{gen} = 50 ohms, See Figures 9, 14 and 15)	$t_{d(on)}$	—	50	ns
Rise Time	t_r	—	120	
Turn-Off Delay Time	$t_{d(off)}$	—	50	
Fall Time	t_f	—	60	
Total Gate Charge (V_{DS} = 0.8 Rated V_{DSS}, I_D = Rated I_D, V_{GS} = 10 V, See Figures 17 and 18)	Q_g	15 (Typ)	26	nC
Gate-Source Charge	Q_{gs}	8 (Typ)	—	
Gate-Drain Charge	Q_{gd}	7 (Typ)	—	
SOURCE DRAIN DIODE CHARACTERISTICS*				
Forward On-Voltage (I_S = 0.5 Rated I_D, V_{GS} = 0)	V_{SD}	1.1 (Typ)	1.5	Vdc
Forward Turn-On Time	t_{on}	Limited by stray inductance		
Reverse Recovery Time	t_{rr}	70 (Typ)	90	ns
INTERNAL PACKAGE INDUCTANCE (TO-204)				
Internal Drain Inductance (Measured from the contact screw on the header closer to the source pin and the center of the die)	L_d	5 (Typ)	—	nH
Internal Source Inductance (Measured from the source pin, 0.25" from the package to the source bond pad)	L_s	12.5 (Typ)	—	
INTERNAL PACKAGE INDUCTANCE (TO-220)				
Internal Drain Inductance (Measured frrom the contact screw on tab to center of die)	L_d	3.5 (Typ)	—	nH
(Measured from the drain lead 0.25" from package to center of die)		4.5 (Typ)	—	
Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad.)	L_s	7.5 (Typ)	—	

*Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

TYPICAL ELECTRICAL CHARACTERISTICS

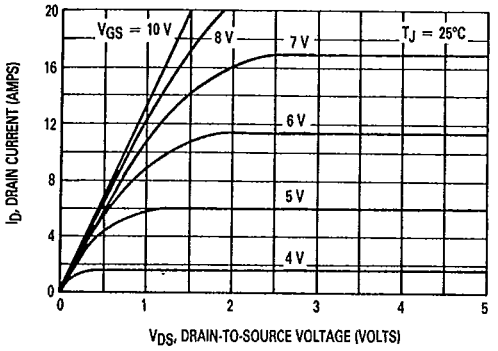


Figure 1. On-Region Characteristics

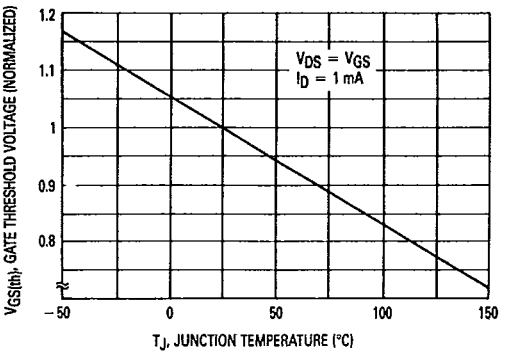


Figure 2. Gate-Threshold Voltage Variation With Temperature

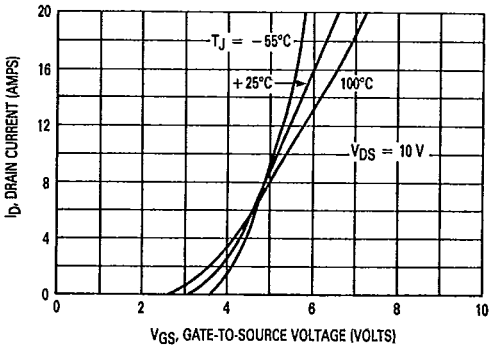


Figure 3. Transfer Characteristics

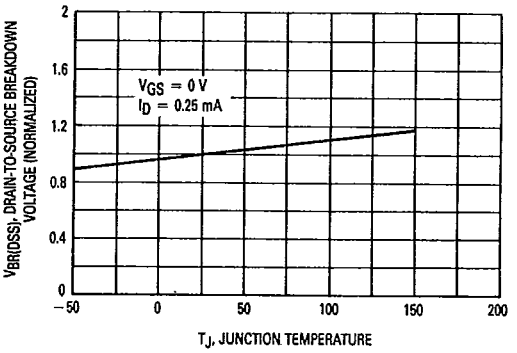


Figure 4. Breakdown Voltage Variation With Temperature

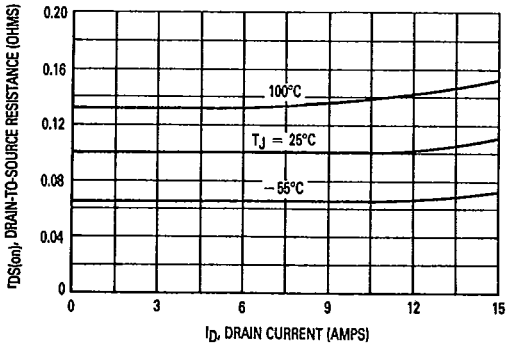


Figure 5. On-Resistance versus Drain Current

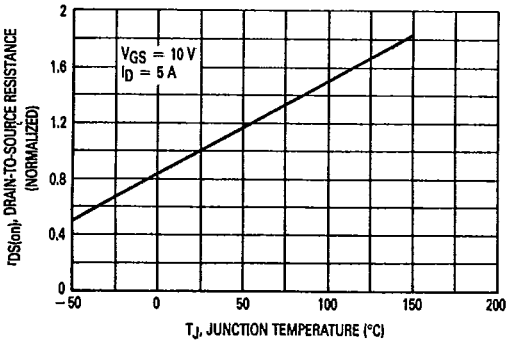


Figure 6. On-Resistance Variation With Temperature

SAFE OPERATING AREA INFORMATION

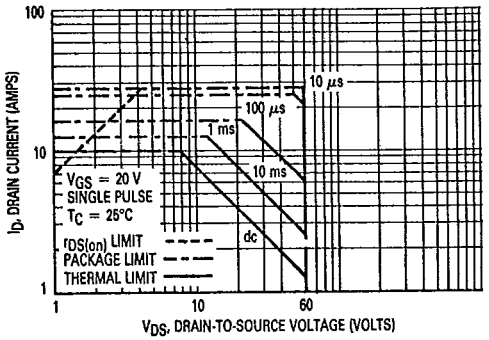


Figure 7. Maximum Rated Forward Biased Safe Operating Area

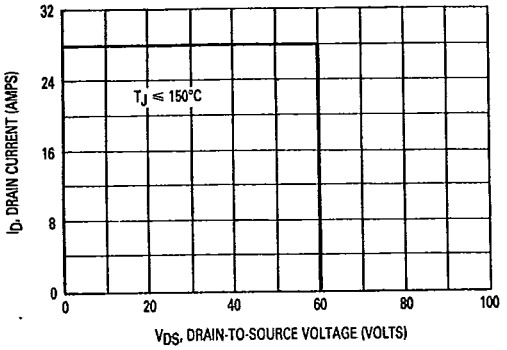


Figure 8. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V_{(BR)DSS}$. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

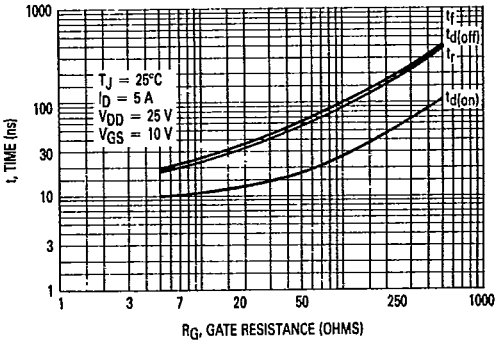


Figure 9. Resistive Switching Time Variation versus Gate Resistance

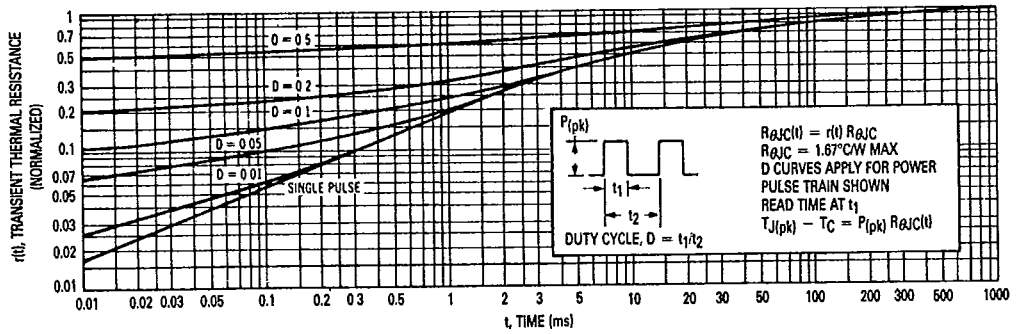


Figure 10. Thermal Response

COMMUTATING SAFE OPERATING AREA (CSOA)

The Commutating Safe Operating Area (CSOA) of Figure 12 defines the limits of safe operation for commutated source-drain current versus re-applied drain voltage when the source-drain diode has undergone forward bias. The curve shows the limitations of I_{FM} and peak V_R for a given commutation speed. It is applicable when waveforms similar to those of Figure 11 are present. Full or half-bridge PWM DC motor controllers are common applications requiring CSOA data.

The time interval t_{frr} is the speed of the commutation cycle. Device stresses increase with commutation speed, so t_{frr} is specified with a minimum value. Faster commutation speeds require an appropriate derating of I_{FM}, peak V_R or both. Ultimately, t_{frr} is limited primarily by device, package, and circuit impedances. Maximum device stress occurs during t_{rr} as the diode goes from conduction to reverse blocking.

$V_{DS(pk)}$ is the peak drain-to-source voltage that the device must sustain during commutation; I_{FM} is the maximum forward source-drain diode current just prior to the onset of commutation.

V_R is specified at 80% of $V_{(BR)DSS}$ to ensure that the CSOA stress is maximized as I_S decays from I_{RM} to zero.

R_{GS} should be minimized during commutation. T_J has only a second order effect on CSOA.

Stray inductances, L_i in Motorola's test circuit are assumed to be practical minimums.

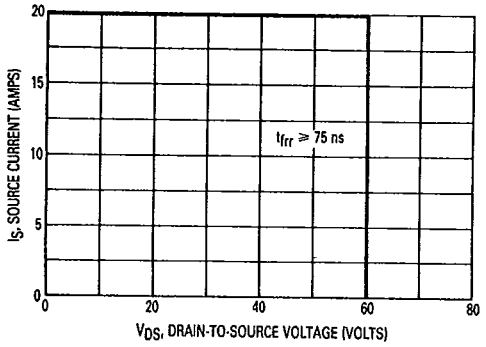


Figure 12. Commutating Safe Operating Area (CSOA)

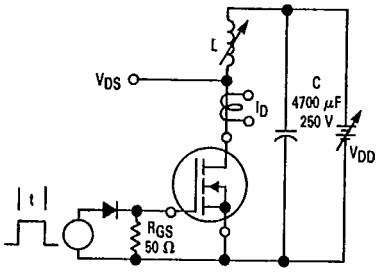


Figure 14. Unclamped Inductive Switching Test Circuit

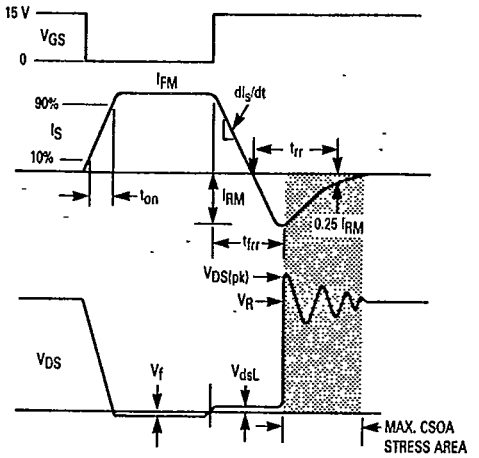


Figure 11. Commutating Waveforms

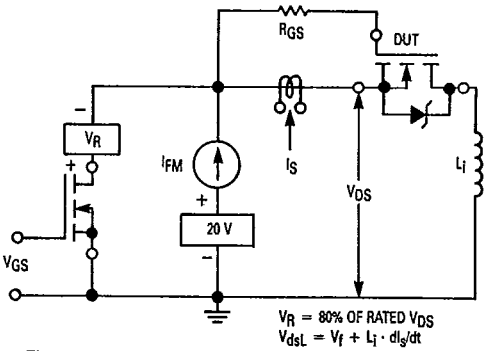


Figure 13. Commutating Safe Operating Area Test Circuit

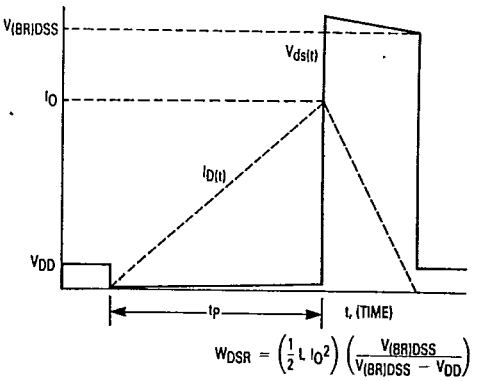


Figure 15. Unclamped Inductive Switching Waveforms

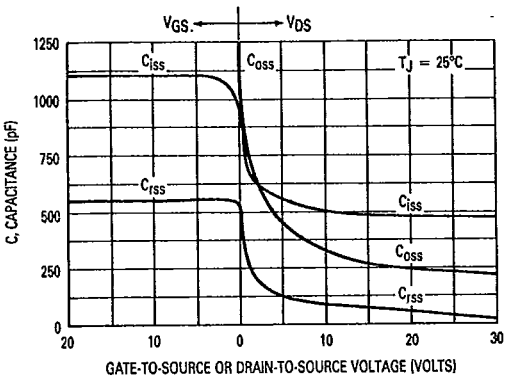


Figure 16. Capacitance Variation

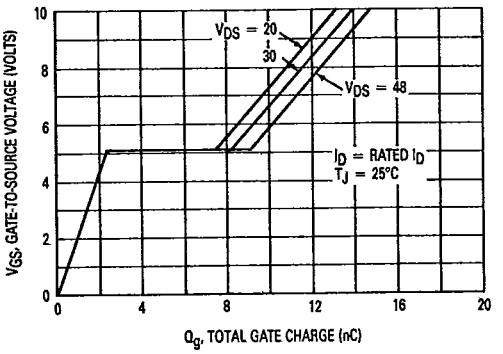
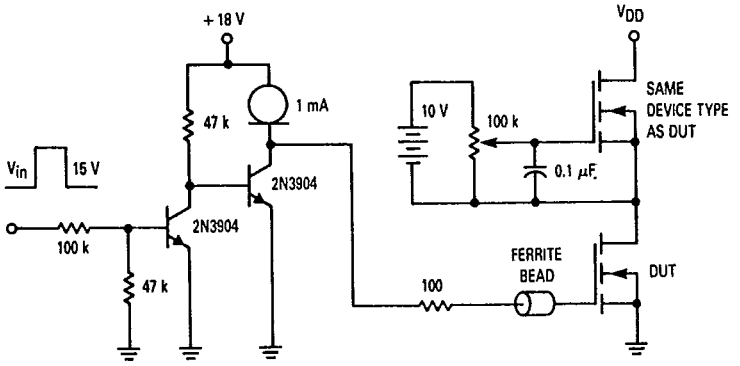


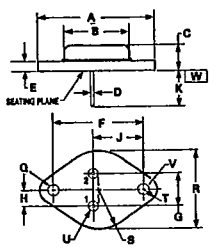
Figure 17. Gate Charge versus Gate-to-Source Voltage



V_{in} = 15 V_{pk}; PULSE WIDTH ≤ 100 μs, DUTY CYCLE ≤ 10%

Figure 18. Gate Charge Test Circuit

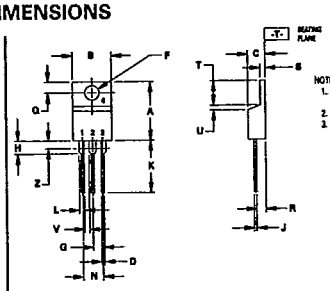
OUTLINE DIMENSIONS



CASE 1-04
MTM10N06E

NOTES:
1. DIAMETER V AND SURFACE W ARE DATUMS.
2. POSITIONAL TOLERANCE FOR HOLE Q:
⌖ ϕ 0.25 (0.010) Ⓜ W V Ⓢ
3. POSITIONAL TOLERANCE FOR LEADS
⌖ ϕ 0.30 (0.012) Ⓜ W V Ⓢ Q Ⓢ

DIM	MILLIMETERS MIN	MAX	INCHES MIN	MAX
A	—	39.37	—	1.550
B	—	21.08	—	0.830
C	8.35	7.62	0.250	0.300
D	0.97	1.09	0.038	0.043
E	1.40	1.78	0.055	0.070
F	30.15 BSC		1.187 BSC	
G	10.92 BSC		0.430 BSC	
H	5.46 BSC		0.215 BSC	
J	16.89 BSC		0.665 BSC	
K	11.18	12.19	0.440	0.480
Q	3.81	4.19	0.151	0.165
R	—	26.67	—	1.050
U	2.54	3.05	0.100	0.120
V	3.81	4.19	0.151	0.165



CASE 221A-04
MTP10N06E

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. ONE Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

DIM	MILLIMETERS MIN	MAX	INCHES MIN	MAX
A	14.48	15.75	0.570	0.620
B	9.66	10.28	0.380	0.405
C	4.07	4.82	0.160	0.190
D	0.64	0.88	0.025	0.035
F	3.61	3.73	0.142	0.147
G	2.42	2.66	0.095	0.105
H	2.80	3.93	0.110	0.155
J	0.36	0.55	0.014	0.022
K	12.70	14.27	0.500	0.562
L	1.15	1.39	0.045	0.055
M	4.83	5.33	0.190	0.210
Q	2.54	3.04	0.100	0.120
R	2.04	2.79	0.080	0.110
S	1.15	1.39	0.045	0.055
T	5.97	6.47	0.235	0.255
U	0.00	1.27	0.000	0.050
V	1.15	—	0.045	—
Z	—	2.04	—	0.080